

TOSHIBA Field Effect Transistor Silicon N-Channel MOS Type (π-MOSVI)

## 2SK3947

### Switching Regulator Applications

- Low drain-source ON-resistance:  $R_{DS(ON)} = 1.1 \Omega$  (typ.)
- High forward transfer admittance:  $|Y_{fs}| = 5.0S$  (typ.)
- Low leakage current:  $I_{DSS} = 100 \mu A$  ( $V_{DS} = 600 V$ )
- Enhancement mode:  $V_{th} = 2.0 \sim 4.0 V$  ( $V_{DS} = 10 V$ ,  $I_D = 1 mA$ )

### Absolute Maximum Ratings ( $T_a = 25^\circ C$ )

| Characteristic                                 |                               | Symbol    | Rating         | Unit       |
|------------------------------------------------|-------------------------------|-----------|----------------|------------|
| Drain-source voltage                           |                               | $V_{DSS}$ | 600            | V          |
| Drain-gate voltage ( $R_{GS} = 20 k\Omega$ )   |                               | $V_{DGR}$ | 600            | V          |
| Gate-source voltage                            |                               | $V_{GSS}$ | $\pm 30$       | V          |
| Drain current                                  | DC (Note 1)                   | $I_D$     | 6              | A          |
|                                                | Pulse ( $t = 1 ms$ ) (Note 1) | $I_{DP}$  | 24             |            |
| Drain power dissipation ( $T_c = 25^\circ C$ ) |                               | $P_D$     | 40             | W          |
| Single-pulse avalanche energy (Note 2)         |                               | $E_{AS}$  | 345            | mJ         |
| Avalanche current                              |                               | $I_{AR}$  | 6              | A          |
| Repetitive avalanche energy (Note 3)           |                               | $E_{AR}$  | 4              | mJ         |
| Channel temperature                            |                               | $T_{ch}$  | 150            | $^\circ C$ |
| Storage temperature range                      |                               | $T_{stg}$ | $-55 \sim 150$ | $^\circ C$ |

Note: Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings. Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/Derating Concept and Methods) and individual reliability data (i.e. reliability test report and estimated failure rate, etc.).

### Thermal Characteristics

| Characteristic                         | Symbol         | Max   | Unit         |
|----------------------------------------|----------------|-------|--------------|
| Thermal resistance, channel to case    | $R_{th(ch-c)}$ | 3.125 | $^\circ C/W$ |
| Thermal resistance, channel to ambient | $R_{th(ch-a)}$ | 62.5  | $^\circ C/W$ |

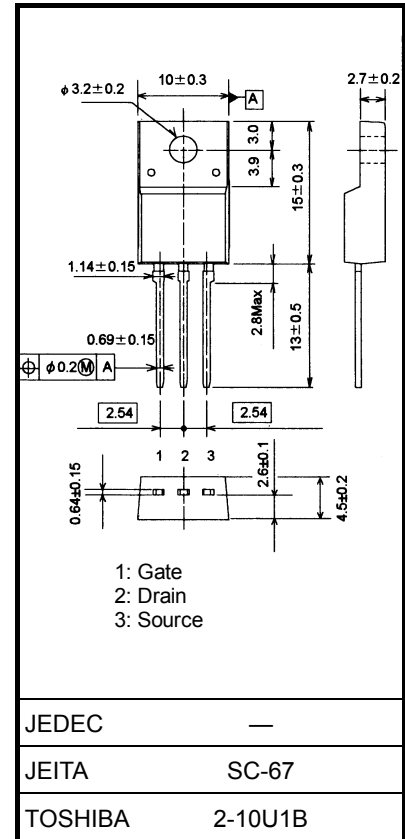
Note 1: Ensure that the channel temperature does not exceed  $150^\circ C$ .

Note 2:  $V_{DD} = 90 V$ ,  $T_{ch} = 25^\circ C$  (initial),  $L = 16.8 mH$ ,  $I_{AR} = 6 A$ ,  $R_G = 25 \Omega$

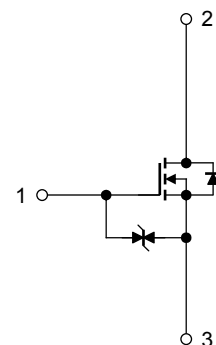
Note 3: Repetitive rating: Pulse width limited by maximum channel temperature

This transistor is an electrostatic-sensitive device. Handle with care.

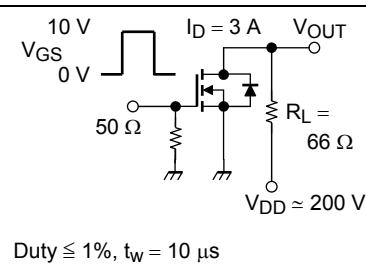
Unit: mm



Weight: 1.7 g (typ.)



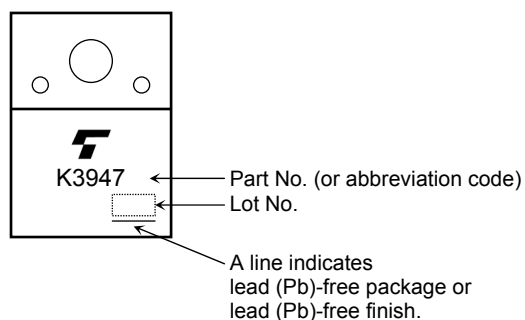
## Electrical Characteristics (Ta = 25°C)

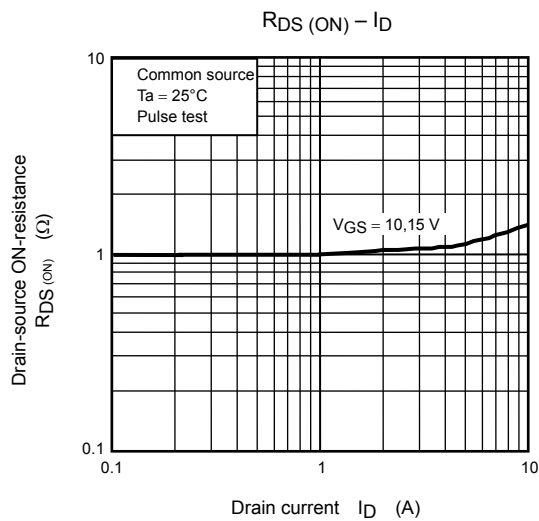
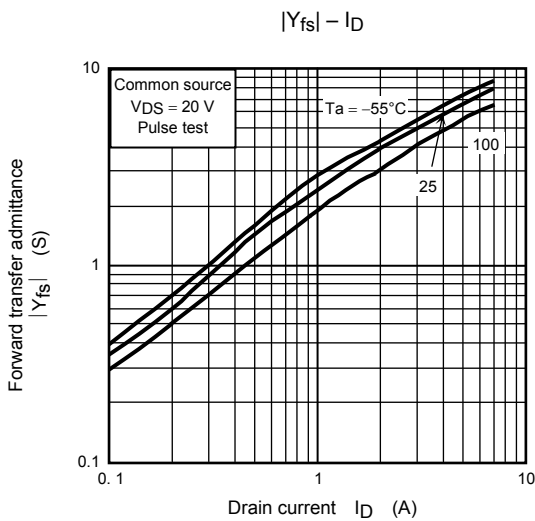
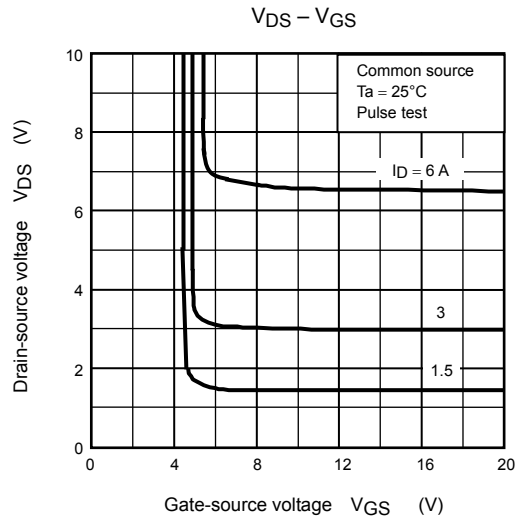
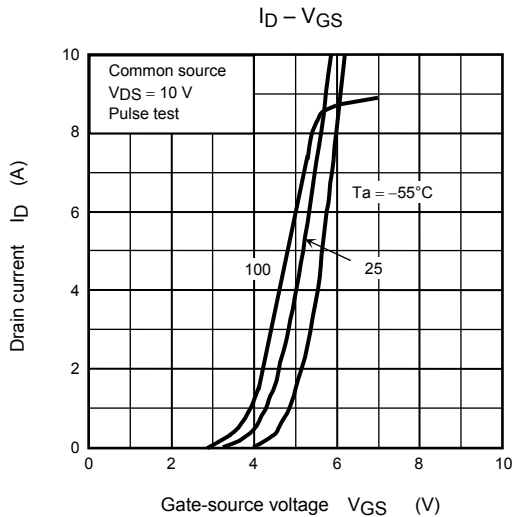
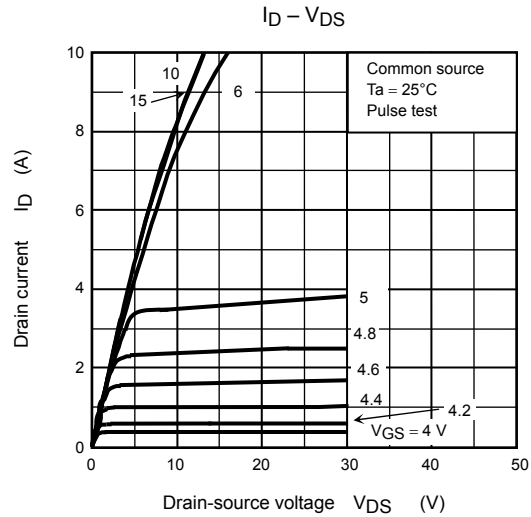
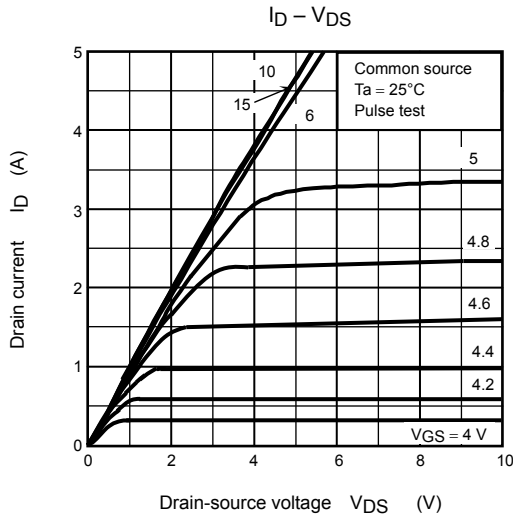
| Characteristic                 |               | Symbol        | Test Condition                                                                     | Min      | Typ. | Max      | Unit          |
|--------------------------------|---------------|---------------|------------------------------------------------------------------------------------|----------|------|----------|---------------|
| Gate leakage current           |               | $I_{GSS}$     | $V_{GS} = \pm 25 \text{ V}, V_{DS} = 0 \text{ V}$                                  | —        | —    | $\pm 10$ | $\mu\text{A}$ |
| Gate-source breakdown voltage  |               | $V_{(BR)GSS}$ | $I_G = \pm 10 \mu\text{A}, V_{GS} = 0 \text{ V}$                                   | $\pm 30$ | —    | —        | V             |
| Drain cutoff current           |               | $I_{DSS}$     | $V_{DS} = 600 \text{ V}, V_{GS} = 0 \text{ V}$                                     | —        | —    | 100      | $\mu\text{A}$ |
| Drain-source breakdown voltage |               | $V_{(BR)DSS}$ | $I_D = 10 \text{ mA}, V_{GS} = 0 \text{ V}$                                        | 600      | —    | —        | V             |
| Gate threshold voltage         |               | $V_{th}$      | $V_{DS} = 10 \text{ V}, I_D = 1 \text{ mA}$                                        | 2.0      | —    | 4.0      | V             |
| Drain-source ON-resistance     |               | $R_{DS(ON)}$  | $V_{GS} = 10 \text{ V}, I_D = 3 \text{ A}$                                         | —        | 1.1  | 1.4      | $\Omega$      |
| Forward transfer admittance    |               | $ Y_{fs} $    | $V_{DS} = 10 \text{ V}, I_D = 3 \text{ A}$                                         | 1.2      | 5.0  | —        | S             |
| Input capacitance              |               | $C_{iss}$     | $V_{DS} = 25 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$                   | —        | 1050 | —        | pF            |
| Reverse transfer capacitance   |               | $C_{rss}$     |                                                                                    | —        | 10   | —        |               |
| Output capacitance             |               | $C_{oss}$     |                                                                                    | —        | 110  | —        |               |
| Switching time                 | Rise time     | $t_r$         |  | —        | 20   | —        | ns            |
|                                | Turn-on time  | $t_{on}$      |                                                                                    | —        | 40   | —        |               |
|                                | Fall time     | $t_f$         |                                                                                    | —        | 35   | —        |               |
|                                | Turn-off time | $t_{off}$     |                                                                                    | —        | 130  | —        |               |
| Total gate charge              |               | $Q_g$         | $V_{DD} \approx 400 \text{ V}, V_{GS} = 10 \text{ V}, I_D = 6 \text{ A}$           | —        | 28   | —        | nC            |
| Gate-source charge             |               | $Q_{gs}$      |                                                                                    | —        | 16   | —        |               |
| Gate-drain charge              |               | $Q_{gd}$      |                                                                                    | —        | 12   | —        |               |

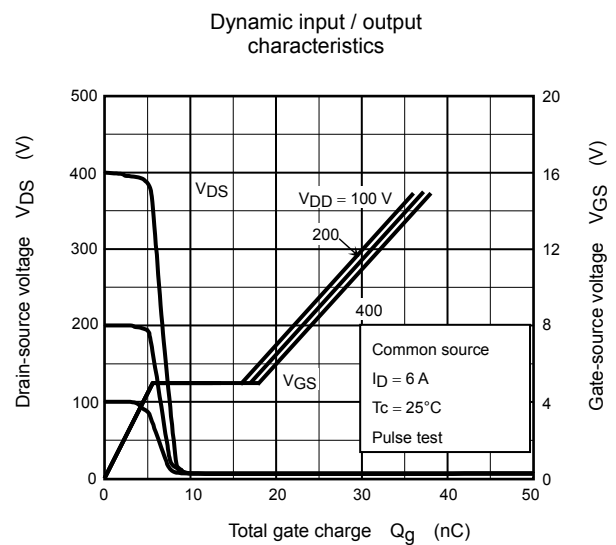
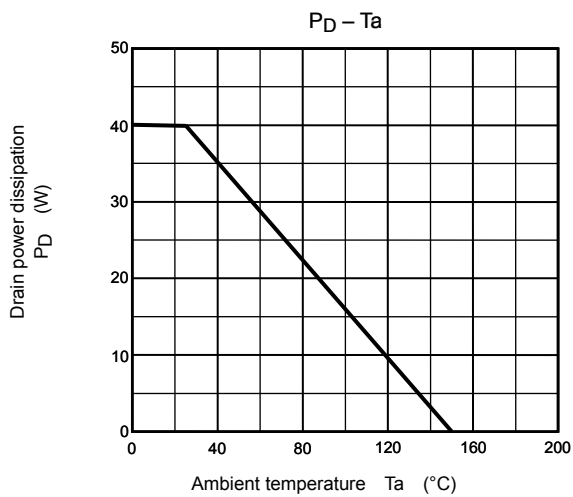
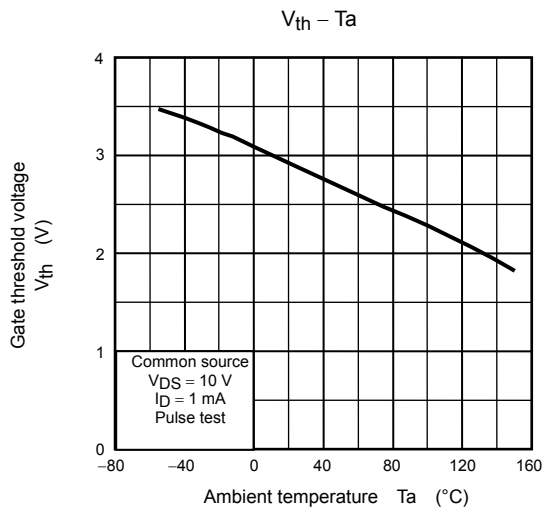
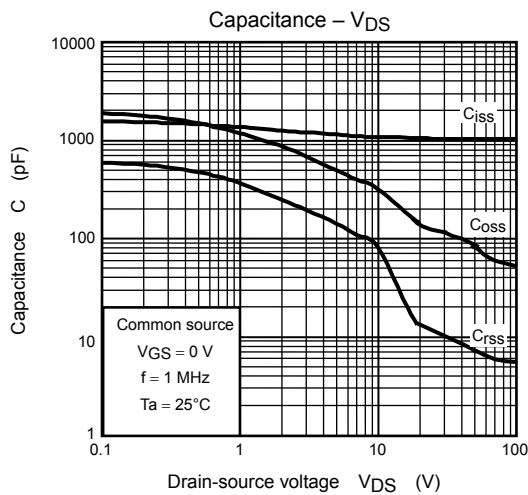
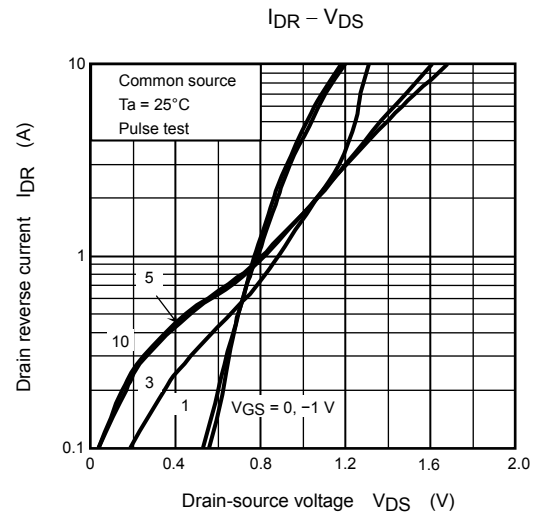
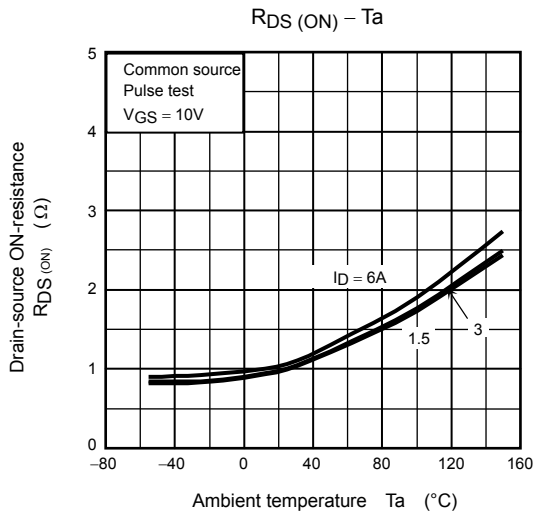
## Source-Drain Ratings and Characteristics (Ta = 25°C)

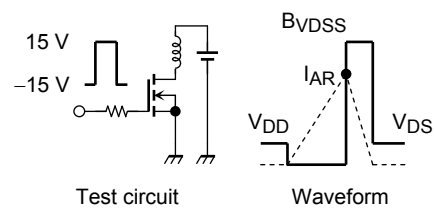
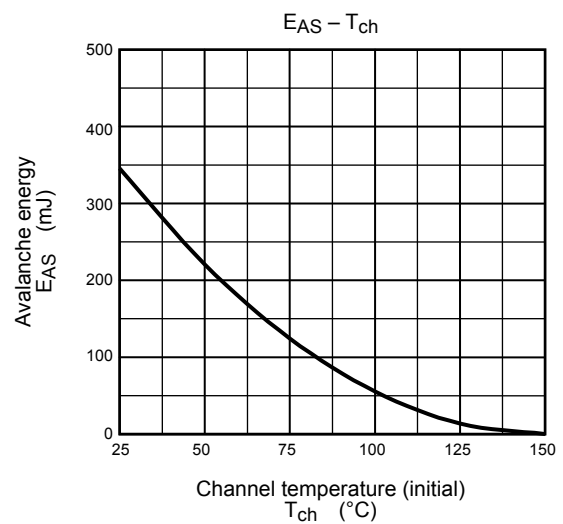
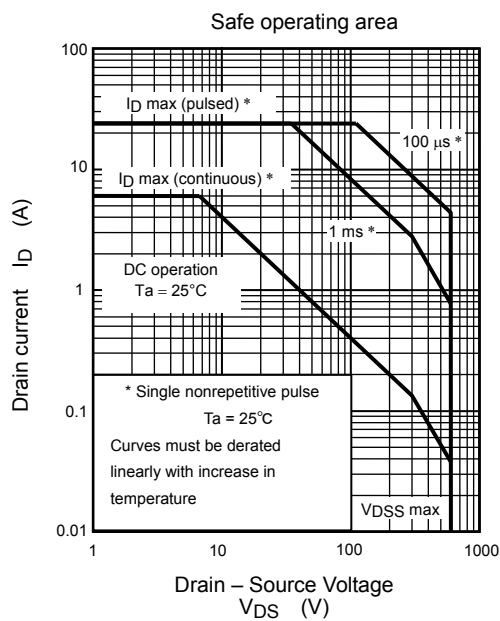
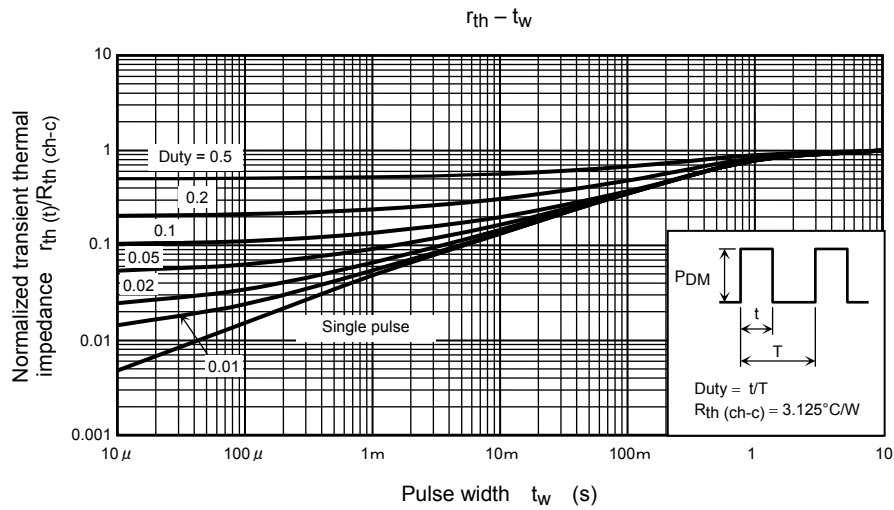
| Characteristic                               | Symbol    | Test Condition                                | Min | Typ. | Max  | Unit          |
|----------------------------------------------|-----------|-----------------------------------------------|-----|------|------|---------------|
| Continuous drain reverse current<br>(Note 1) | $I_{DR}$  | —                                             | —   | —    | 6    | A             |
| Pulse drain reverse current<br>(Note 1)      | $I_{DRP}$ | —                                             | —   | —    | 24   | A             |
| Forward voltage (diode)                      | $V_{DSF}$ | $I_{DR} = 6 \text{ A}, V_{GS} = 0 \text{ V}$  | —   | —    | -1.7 | V             |
| Reverse recovery time                        | $t_{rr}$  | $I_{DR} = 6 \text{ A}, V_{GS} = 0 \text{ V},$ | —   | 140  | —    | ns            |
| Reverse recovery charge                      | $Q_{rr}$  | $dI_{DR}/dt = 100 \text{ A}/\mu\text{s}$      | —   | 0.3  | —    | $\mu\text{C}$ |

## Marking









$$R_G = 25 \Omega$$

$$V_{DD} = 90 V, L = 16.8 mH$$

$$E_{AS} = \frac{1}{2} \cdot L \cdot I^2 \cdot \left( \frac{B_{VDSS}}{B_{VDSS} - V_{DD}} \right)$$

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